# **ON Semiconductor**

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# **MOSFET** - Power, Single

# **P-Channel**

-40 V, 2.7 mΩ, -183 A

# **NVMFS3D0P04M8L**

#### **Features**

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- High Current Capability
- Avalanche Energy Specified
- NVMFWS3D0P04M8L Wettable Flanks Product
- NVM Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V <sub>DSS</sub>	-40	V
Gate-to-Source Voltage			V <sub>GS</sub>	±20	V
Continuous Drain Cur-		T <sub>C</sub> = 25°C	I <sub>D</sub>	-183	Α
rent $R_{\theta JC}$ (Notes 1, 2, 3)	Steady	T <sub>C</sub> = 100°C		-129	
Power Dissipation R <sub>θJC</sub>	State	T <sub>C</sub> = 25°C	$P_{D}$	171	W
(Notes 1, 2)		T <sub>C</sub> = 100°C		86	
Continuous Drain Cur-	Steady State	T <sub>A</sub> = 25°C	I <sub>D</sub>	-28	Α
rent $R_{\theta JA}$ (Notes 1, 2, 3)		T <sub>A</sub> = 100°C		-19	
Power Dissipation $R_{\theta JA}$ (Notes 1, 2)		T <sub>A</sub> = 25°C	$P_{D}$	3.9	W
		T <sub>A</sub> = 100°C		1.9	
Pulsed Drain Current	T <sub>A</sub> = 25°	C, t <sub>p</sub> = 10 μs	I <sub>DM</sub>	-900	Α
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	°C
Source Current (Body Diode)			I <sub>S</sub>	-143	Α
Single Pulse Drain-to-Source Avalanche Energy (I <sub>L(pk)</sub> = -30 A)			E <sub>AS</sub>	752	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Drain) (Note 2)	$R_{\theta JC}$	0.9	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	39	°C/W

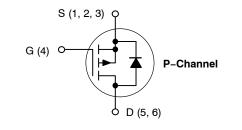
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.
- 3. Continuous DC current rating. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

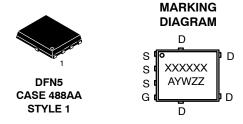


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V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub>	I <sub>D</sub>	
-40 V	2.7 m $\Omega$ @ –10 V	–183 A	
	4.2 mΩ @ -4.5 V	-100 A	





A = Assembly Location Y = Year

W = Work Week
ZZ = Lot Traceability

### **ORDERING INFORMATION**

See detailed ordering, marking and shipping information on page 5 of this data sheet.

### **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Cond	dition	Min	Тур	Max	Unit
OFF CHARACTERISTICS	<u> </u>		•			1	
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$		-40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				12		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = -40 V	$T_J = 25^{\circ}C$ $T_J = 125^{\circ}C$			-1.0 -100	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$				± 100	nA
ON CHARACTERISTICS (Note 4)	455	D0 / d0	,				1
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}$ , $I_D = -2 \text{ mA}$		-1.0		-2.4	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>	VGS - VDS, ID - 2 IIV			-4.7		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = -10 V, I <sub>D</sub> = -30 A			2.1	2.7	mΩ
		V <sub>GS</sub> = -4.5 V,	<sub>D</sub> = -15 A		3.1	4.2	1
Froward Transconductance	9FS	V <sub>DS</sub> = -24 V, I <sub>D</sub> = -50 A			205		S
CHARGES AND CAPACITANCES	•		•			•	•
Input Capacitance	C <sub>iss</sub>	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz,}$ $V_{DS} = -20 \text{ V}$			5827		pF
Output Capacitance	C <sub>oss</sub>				3225		-
Reverse Transfer Capacitance	C <sub>rss</sub>				85.8		
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{DS} = -20 \text{ V},$ $I_{D} = -50 \text{ A}$	V <sub>GS</sub> = -4.5 V		58.7		nC
			V <sub>GS</sub> = -10 V		124		1
Threshold Gate Charge	Q <sub>G(TH)</sub>	$V_{GS} = -10 \text{ V}, V_{DS} = -20 \text{ V},$ $I_{D} = -50 \text{ A}$			10.9		1
Gate-to-Source Charge	Q <sub>GS</sub>				21.6		1
Gate-to-Drain Charge	$Q_{GD}$	$I_D = -50$	ĎΑ		17.3		1
Plateau Voltage	V <sub>GP</sub>		-		2.8		V
SWITCHING CHARACTERISTICS (No	otes 4)		•			•	•
Turn-On Delay Time	t <sub>d(on)</sub>	$V_{GS}$ = -4.5 V, $V_{DS}$ = -20 V, $I_{D}$ = -50 A, $R_{G}$ = 2.5 $\Omega$			15.8		ns
Rise Time	t <sub>r</sub>				161		
Turn-Off Delay Time	t <sub>d(off)</sub>				349		
Fall Time	t <sub>f</sub>				256		1
DRAIN-SOURCE DIODE CHARACTE	RISTICS					•	•
Forward Diode Voltage	V <sub>SD</sub>	$V_{GS} = 0 V,$ $I_{S} = -15 A$	T <sub>J</sub> = 25°C		-0.75	-1.20	V
			T <sub>J</sub> = 125°C		-0.61		1
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 \text{ V, } dl_{S}/dt = 100 \text{ A}/\mu\text{s,}$ $l_{S} = -50 \text{ A}$			113		ns
Charge Time	t <sub>a</sub>				59.4		1
Discharge Time	t <sub>b</sub>				53.1		1
Reverse Recovery Charge	Q <sub>RR</sub>				246		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 4. Pulse Test: Pulse Width  $\leq$  300  $\mu$ s, Duty Cycle  $\leq$  2%.

### **TYPICAL CHARACTERISTICS**

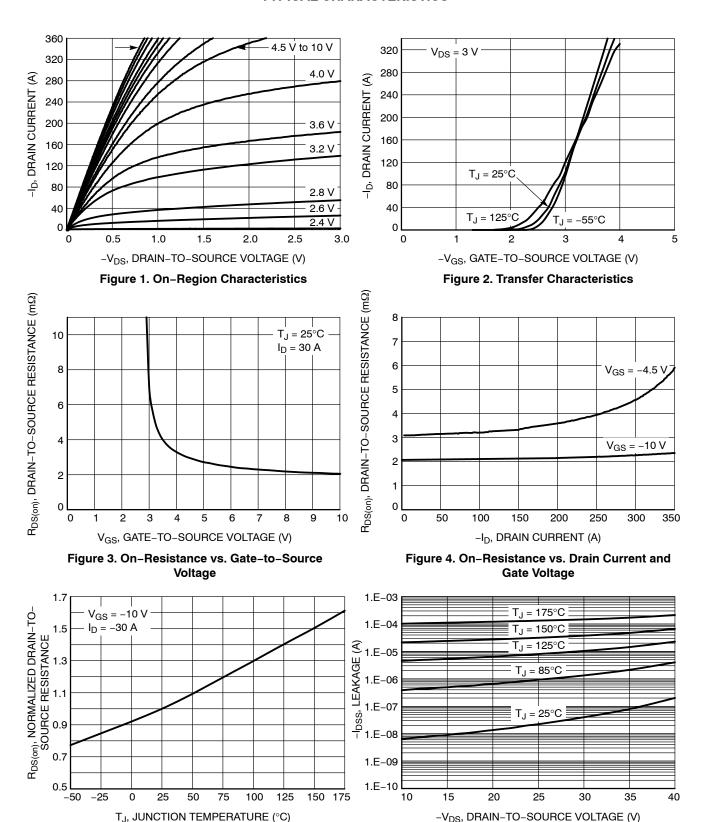


Figure 6. Drain-to-Source Leakage Current

vs. Voltage

Figure 5. On-Resistance Variation with

**Temperature** 

### TYPICAL CHARACTERISTICS

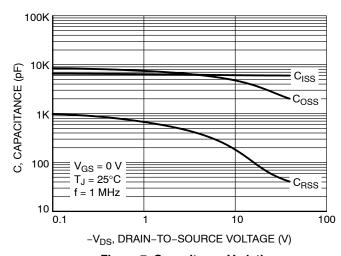


Figure 7. Capacitance Variation

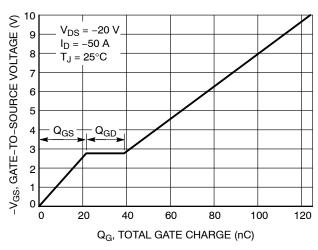


Figure 8. Gate-to-Source vs. Total Charge

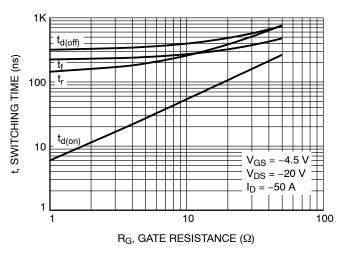


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

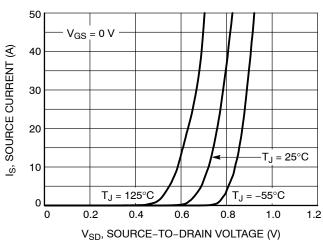


Figure 10. Diode Forward Voltage vs. Current

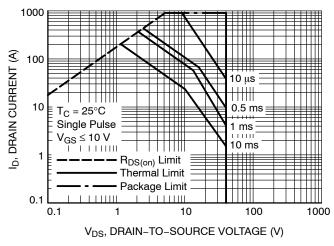


Figure 11. Maximum Rated Forward Biased Safe Operating Area

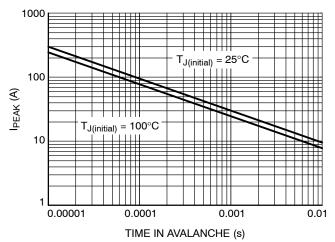


Figure 12. Maximum Drain Current vs. Time in Avalanche

### **TYPICAL CHARACTERISTICS**

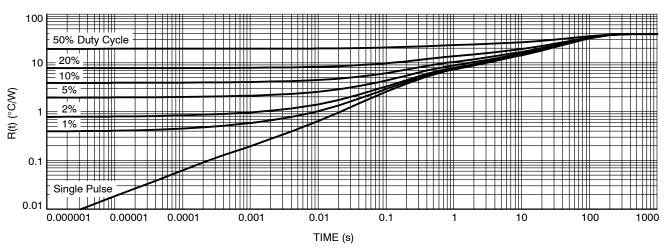


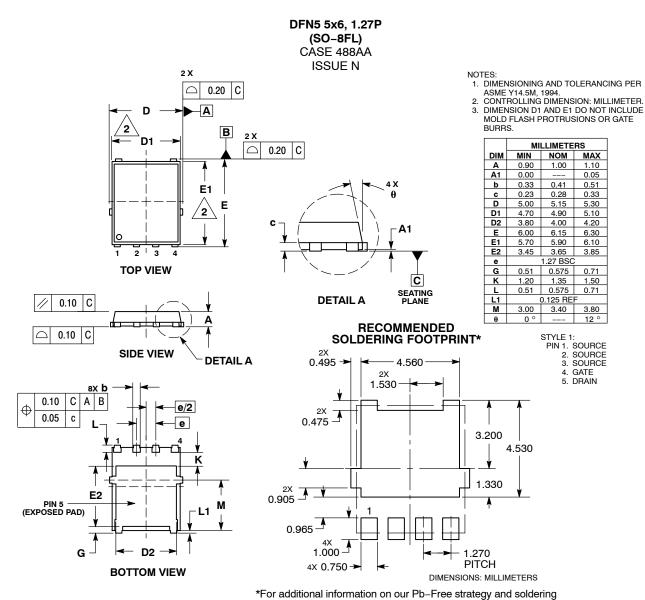
Figure 13. Thermal Response

### **DEVICE ORDERING INFORMATION**

Device	Marking	Package	Shipping <sup>†</sup>
NVMFS3D0P04M8LT1G	3D0P04	DFN5 (Pb-Free)	1500 / Tape & Reel
NVMFWS3D0P04M8LT1G	3D0P4W	DFN5 (Pb-Free)	1500 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

### PACKAGE DIMENSIONS



details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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